

Notice of References Cited

Application/Control No.

09/451,628

Applicant(s)/Patent Under
Reexamination
TEPMAN ET AL.

Examiner

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Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	WO 99/03137	01-1999	PCT	Lei et al.	----
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NON-PATENT DOCUMENTS

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